

# DIGITRON SEMICONDUCTORS

3N211-3N213

DUAL-GATE VHF AMPLIFIER  
N-CHANNEL - DEPLETION

## MAXIMUM RATINGS

Rating	Symbol	3N211 3N212	3N213	Unit
Drain Source Voltage	$V_{DS}$	27	35	Vdc
Drain Gate Voltage	$V_{DG1}$ $V_{DG2}$	35 35	40 40	Vdc
Drain Current	$I_D$	50		mAdc
Gate Current	$I_{G1}$ $I_{G2}$	$\pm 10$ $\pm 10$		mAdc
Total Device Dissipation @ $T_A = 25^\circ\text{C}$ Derate above $25^\circ\text{C}$	$P_D$	360 2.4		mW mW/ $^\circ\text{C}$
Total Device Dissipation @ $T_C = 25^\circ\text{C}$ Derate above $25^\circ\text{C}$	$P_D$	1.2 8.0		Watt mW/ $^\circ\text{C}$
Lead Temperature, 1/16" from Seated Surface for 10 seconds	$T_L$	300		$^\circ\text{C}$
Junction Temperature Range	$T_J$	-65 to +175		$^\circ\text{C}$
Storage Temperature Range	$T_{stg}$	-65 to +175		$^\circ\text{C}$

## ELECTRICAL CHARACTERISTICS ( $T_A = 25^\circ$ unless otherwise noted)

Characteristics		Symbol	Min	Max	Unit
<b>OFF CHARACTERISTICS</b>					
Drain Source Breakdown Voltage <sup>(1)</sup> ( $I_D = 10 \mu\text{Adc}$ , $V_{G1S} = V_{G2S} = -4.0 \text{ Vdc}$ )	3N211, 3N212 3N213	$V_{(BR)DSX}$	25 30	- -	Vdc
Instantaneous Drain Source Breakdown Voltage ( $I_D = 10 \mu\text{Adc}$ , $V_{G1S} = V_{G2S} = -4.0 \text{ Vdc}$ )	3N211, 3N212 3N213	$V_{(BR)DSX}$	27 35	- -	Vdc
Gate 1 – Source Breakdown Voltage <sup>(2)</sup> ( $I_{G1} = \pm 10 \text{ mAdc}$ , $V_{G2S} = V_{DS} = 0$ )		$V_{(BR)G1S0}$	$\pm 6.0$	-	Vdc
Gate 2 – Source Breakdown Voltage <sup>(2)</sup> ( $I_{G2} = \pm 10 \text{ mAdc}$ , $V_{G1S} = V_{DS} = 0$ )		$V_{(BR)G2S0}$	$\pm 6.0$	-	Vdc
Gate 1 Leakage Current ( $V_{G1S} = \pm 5.0 \text{ Vdc}$ , $V_{G2S} = V_{DS} = 0$ ) ( $V_{G1S} = -5.0 \text{ Vdc}$ , $V_{G2S} = V_{DS} = 0$ , $T_A = 150^\circ\text{C}$ )		$I_{G1SS}$	- -	$\pm 10$ -10	nAdc $\mu\text{Adc}$
Gate 2 Leakage Current ( $V_{G2S} = \pm 5.0 \text{ Vdc}$ , $V_{G1S} = V_{DS} = 0$ ) ( $V_{G2S} = -5.0 \text{ Vdc}$ , $V_{G1S} = V_{DS} = 0$ , $T_A = 150^\circ\text{C}$ )		$I_{G2SS}$	- -	$\pm 10$ -10	nAdc $\mu\text{Adc}$
Gate 1 to Source Cutoff Voltage ( $V_{DS} = 15 \text{ Vdc}$ , $V_{G2S} = 4.0 \text{ Vdc}$ , $I_D = 20 \mu\text{Adc}$ )	3N211, 3N212 3N212	$V_{G1S(off)}$	-0.5 -0.5	-5.5 -4.0	Vdc
Gate 2 Source to Cutoff Voltage ( $V_{DS} = 15 \text{ Vdc}$ , $V_{G1S} = 0$ , $I_D = 20 \mu\text{Adc}$ )	3N211 3N212, 3N213	$V_{G2S(off)}$	-0.2 -0.2	-2.5 -4.0	Vdc
<b>ON CHARACTERISTICS</b>					
Zero Gate Voltage Drain Current <sup>(3)</sup> ( $V_{DS} = 15 \text{ Vdc}$ , $V_{G1S} = 0$ , $V_{G2S} = 4.0 \text{ Vdc}$ )		$I_{DSS}$	6.0	40	mAdc
<b>SMALL SIGNAL CHARACTERISTICS</b>					
Forward Transfer Admittance <sup>(4)</sup> ( $V_{DS} = 15 \text{ Vdc}$ , $V_{G2S} = 4.0 \text{ Vdc}$ , $V_{G1S} = 0$ , $f = 1.0 \text{ kHz}$ )	3N211, 3N212 3N213	$ y_{fs} $	17 15	40 35	mmhos
Reverse Transfer Capacitance ( $V_{DS} = 15 \text{ Vdc}$ , $V_{G2S} = 4.0 \text{ Vdc}$ , $I_D = 1.0 \text{ mAdc}$ , $f = 1.0 \text{ MHz}$ )		$C_{rss}$	0.005	0.05	pF
<b>FUNCTIONAL CHARACTERISTICS</b>					
Noise Figure ( $V_{DD} = 18 \text{ Vdc}$ , $V_{GG} = 7.0 \text{ Vdc}$ , $f = 200 \text{ MHz}$ ) ( $V_{DD} = 24 \text{ Vdc}$ , $V_{GG} = 6.0 \text{ Vdc}$ , $f = 45 \text{ MHz}$ )	3N211 3N211, 3N213	NF	- -	3.5 4.0	dB

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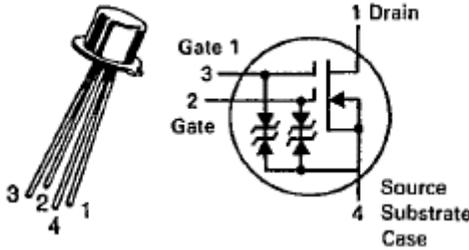
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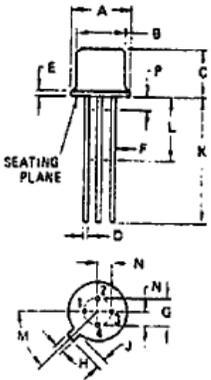
**ELECTRICAL CHARACTERISTICS (T<sub>A</sub> = 25° unless otherwise noted)**

Characteristics	Symbol	Min	Max	Unit	
<b>FUNCTIONAL CHARACTERISTICS (con't)</b>					
<b>Common Source Power Gain</b>		G <sub>ps</sub>	24	35	dB
(V <sub>DD</sub> = 18 Vdc, V <sub>GG</sub> = 7.0 Vdc, f = 200 MHz)	3N211				
(V <sub>DD</sub> = 24 Vdc, V <sub>GG</sub> = 6.0 Vdc, f = 45 MHz)	3N211				
(V <sub>DD</sub> = 24 Vdc, V <sub>GG</sub> = 6.0 Vdc, f = 45 MHz)	3N213				
(V <sub>DD</sub> = 18 Vdc, f <sub>LO</sub> = 245 MHz, f <sub>RF</sub> = 200 MHz)	3N212				
<b>Bandwidth</b>		BW	5.0	12	MHz
(V <sub>DD</sub> = 18 Vdc, V <sub>GG</sub> = 7.0 Vdc, f = 200 MHz)	3N211				
(V <sub>DD</sub> = 18 Vdc, f <sub>LO</sub> = 245 MHz, f <sub>RF</sub> = 200 MHz)	3N212				
(V <sub>DD</sub> = 24 Vdc, V <sub>GG</sub> = 6.0 Vdc, f = 45 MHz)	3N211, 3N213				
<b>Gain Control Gate Supply Voltage<sup>(5)</sup></b>		V <sub>gg(gc)</sub>	-	-2.0	Vdc
(V <sub>DD</sub> = 18 Vdc, Δ Gps = -30 dB, f = 200 MHz)	3N211				
(V <sub>DD</sub> = 24 Vdc, Δ Gps = -30 dB, f = 45 MHz)	3N211, 3N213	-	±1.0		

- (1) Measured after five seconds of applied voltage.
- (2) All gate breakdown voltages are measured while the device is conducting rated gate current. This ensures that the gate voltage limiting network is functioning properly.
- (3) Pulse test: Pulse width = 300μs, Duty cycle ≤ 2.0%.
- (4) This parameter must be measured with bias voltages applied for less than 5 seconds to avoid overheating. The signal is applied to gate 1 with gate 2 at ac ground.
- (5) Δ Gps is defined as the change in G<sub>ps</sub> from the value at V<sub>GG</sub> = 7.0 Volts (3N211) and V<sub>GG</sub> = 6.0 Volts (3N213).
- (6) Power Gain Conversion. Amplitude at input from local oscillator is adjusted for maximum G<sub>c</sub>.



**TO-72**



Dim	Inches		Millimeters	
	Min	Max	Min	Max
A	-	0.230	-	5.840
B	-	0.195	-	4.950
C	-	0.210	-	5.330
D	-	0.021	-	0.530
E	-	0.030	-	0.760
F	-	0.019	-	0.480
G	0.100 BSC	-	2.540 BSC	-
H	-	0.046	-	1.170
J	-	0.0480	-	1.220
K	0.500	-	12.700	-
L	0.250	-	6.350	-
M	45°C BSC	-	45°C BSC	-
N	0.050 BSC	-	1.270 BSC	-
P	-	0.050	-	1.270

Available Non-RoHS (standard) or RoHS compliant (add PBF suffix).  
 Available as "HR" (high reliability) screened per MIL-PRF-19500, JANTX level. Add "HR" suffix to base part number.